Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,143	SUH ET AL.
Examiner	Art Unit
Leonard M. Williams	1617

SEARCHED				
Class	Subclass	Date	Examiner	
514	152	11/29/2005	LMW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR)
	DATE	EXMR
PALM YOO-HUN-SUH HYE-SUN KIM CHEOL-HYOUNG PARK KI-YOUNG SHIN	11/29/2005	LMW
EAST YOO-HUN-SUH HYE-SUN KIM CHEOL-HYOUNG PARK KI-YOUNG SHIN	11/29/2005	LMW